

Emergence of half metallicity in Cr-doped GaP dilute magnetic semiconductor compound within solubility limit

Abstract

The electronic and magnetic properties of $\text{Ga}_{1-x}\text{Cr}_x\text{P}$ dilute magnetic semiconductor (DMS) compound for dopant concentration, $x = 0.25, 0.125, 0.06$ and 0.03 have been investigated using WIEN2k implementation of full potential linearized augmented plane wave (FP-LAPW) method in order to seek out the possibility of new dilute magnetic semiconductor (DMS) compound within generalized gradient approximation (GGA) as exchange-correlation (XC) potential. The calculated results show that the Cr doping in GaP induces the ferromagnetism and originates a half metallic (HM) gap at Fermi level (E_F) in minority spin channel (MIC) for all concentrations. The half metallicity is originated by the hybridization of Cr-d states with P-p states. Moreover, the half metallicity remains intact for all Cr-concentration. We also observed that the HM gap increases with the reduction in doping concentration from 0.25 to 0.03. The total magnetic moment of this compound is mainly due to Cr-d states present at E_F . A small induced magnetic moment on other non magnetic atoms (Ga and P) for all doping concentrations is a consequence of p-d hybridization between Cr-d and P-p states.